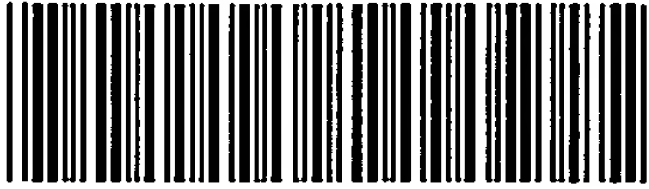


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/920,921	OOTANI ET AL.	
	Examiner	Art Unit	
	Ba Huynh	2179	

SEARCHED			
Class	Subclass	Date	Examiner
715	734	11/12/2005	HB
	735		
	736		
	848		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East: USpat, USpgpub, Epo, Jpo, Derwent, IBM-tdb files search updated. NPL search updated.	11/12/2005	HB